

Notice of References Cited	Application/Control No. 10/064,613	Applicant(s)/Patent Under Reexamination KAO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,069,609	05-2000	Ishida et al.	345/596
	B	US-6,069,610	05-2000	Denda et al.	345/694
	C	US-6,473,091	10-2002	Iida et al.	345/589
	D	US-2002/0015010	02-2002	Takahashi, Yasunori	345/60
	E	US-2002/0027566	03-2002	Naka et al.	345/696
	F	US-2002/0135595	09-2002	Morita et al.	345/589
	G	US-2003/0231148	12-2003	Lin et al.	345/63
	H	US-6,088,009	07-2000	Moon, Seong Hak	345/60
	I	US-6,486,859	11-2002	Croll et al.	345/72
	J	US-6,671,068	12-2003	Chang et al.	382/252
	K	US-2002/0067510	06-2002	Kempf, Jeffrey	358/3.03
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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